

## DATASHEET

# UF3C065080B7S

## 650V-85mΩ SiC FET

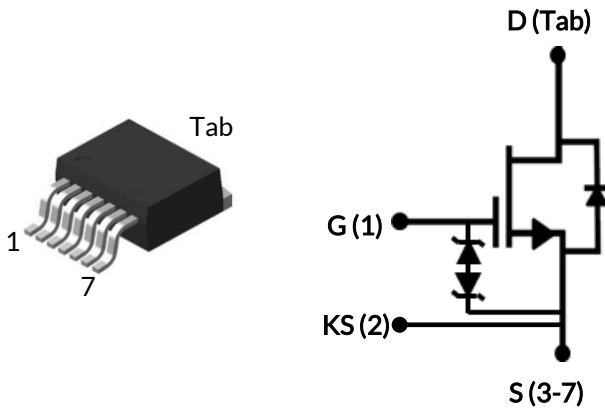
Rev. A, November 2020

### Description

This SiC FET device is based on a unique ‘cascode’ circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device’s standard gate-drive characteristics allows for a true “drop-in replacement” to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the D<sup>2</sup>PAK-7L package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads, and any application requiring standard gate drive.

### Features

- ◆ On-resistance  $R_{DS(on)}$ : 85mΩ (typ)
- ◆ Operating temperature: 175°C (max)
- ◆ Excellent reverse recovery:  $Q_{rr}$  = 69nC
- ◆ Low body diode  $V_{FSD}$ : 1.54V
- ◆ Low gate charge:  $Q_G$  = 23nC
- ◆ Threshold voltage  $V_{G(th)}$ : 4.8V (typ) allowing 0 to 15V drive
- ◆ Package creepage and clearance distance > 6.1mm
- ◆ Kelvin source pin for optimized switching performance
- ◆ ESD protected, HBM class 2



Part Number	Package	Marking
UF3C065080B7S	D <sup>2</sup> PAK-7L	UF3C065080B7S

### Typical applications

- Any controlled environment such as
- ◆ Telecom and Server Power
  - ◆ Industrial power supplies
  - ◆ Power factor correction modules
  - ◆ Motor drives
  - ◆ Induction heating



## Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	$V_{DS}$		650	V
Gate-source voltage	$V_{GS}$	DC	-25 to +25	V
Continuous drain current <sup>1</sup>	$I_D$	$T_C = 25^\circ\text{C}$	27	A
		$T_C = 100^\circ\text{C}$	20	A
Pulsed drain current <sup>2</sup>	$I_{DM}$	$T_C = 25^\circ\text{C}$	65	A
Single pulsed avalanche energy <sup>3</sup>	$E_{AS}$	$L=15\text{mH}, I_{AS}=2.1\text{A}$	33	mJ
Power dissipation	$P_{tot}$	$T_C = 25^\circ\text{C}$	136.4	W
Maximum junction temperature	$T_{J,max}$		175	$^\circ\text{C}$
Operating and storage temperature	$T_J, T_{STG}$		-55 to 175	$^\circ\text{C}$
Reflow soldering temperature	$T_{solder}$	reflow MSL 3	260	$^\circ\text{C}$

1. Limited by  $T_{J,max}$

2. Pulse width  $t_p$  limited by  $T_{J,max}$

3. Starting  $T_J = 25^\circ\text{C}$

## Thermal Characteristics

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Thermal resistance, junction-to-case	$R_{\theta JC}$			0.83	1.1	$^\circ\text{C}/\text{W}$

## Electrical Characteristics ( $T_J = +25^\circ\text{C}$ unless otherwise specified)

### Typical Performance - Static

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Drain-source breakdown voltage	$BV_{DS}$	$V_{GS}=0V, I_D=1mA$	650			V
Total drain leakage current	$I_{DSS}$	$V_{DS}=650V,$ $V_{GS}=0V, T_J=25^\circ\text{C}$		1.3	100	$\mu\text{A}$
		$V_{DS}=650V,$ $V_{GS}=0V, T_J=175^\circ\text{C}$		10		
Total gate leakage current	$I_{GSS}$	$V_{DS}=0V, T_J=25^\circ\text{C},$ $V_{GS}=-20V / +20V$		6	$\pm 20$	$\mu\text{A}$
Drain-source on-resistance	$R_{DS(on)}$	$V_{GS}=12V, I_D=20A,$ $T_J=25^\circ\text{C}$		85	105	m $\Omega$
		$V_{GS}=12V, I_D=20A,$ $T_J=125^\circ\text{C}$		116		
		$V_{GS}=12V, I_D=20A,$ $T_J=175^\circ\text{C}$		146		
Gate threshold voltage	$V_{G(th)}$	$V_{DS}=5V, I_D=10mA$	4	4.8	6	V
Gate resistance	$R_G$	f=1MHz, open drain		4.2		$\Omega$

### Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Diode continuous forward current <sup>1</sup>	$I_S$	$T_C=25^\circ\text{C}$			27	A
Diode pulse current <sup>2</sup>	$I_{S,pulse}$	$T_C=25^\circ\text{C}$			65	A
Forward voltage	$V_{FSD}$	$V_{GS}=0V, I_F=10A,$ $T_J=25^\circ\text{C}$		1.54	2	V
		$V_{GS}=0V, I_F=10A,$ $T_J=175^\circ\text{C}$		1.85		
Reverse recovery charge	$Q_{rr}$	$V_R=400V, I_F=20A,$ $V_{GS}=-5V, R_{G,EXT}=22\Omega$ $di/dt=2000A/\mu\text{s},$ $T_J=25^\circ\text{C}$		69		nC
Reverse recovery time	$t_{rr}$	$T_J=25^\circ\text{C}$		21		ns
Reverse recovery charge	$Q_{rr}$	$V_R=400V, I_F=20A,$ $V_{GS}=-5V, R_{G,EXT}=22\Omega$ $di/dt=2000A/\mu\text{s},$ $T_J=150^\circ\text{C}$		66		nC
Reverse recovery time	$t_{rr}$	$T_J=150^\circ\text{C}$		19		ns

## Typical Performance - Dynamic

Parameter	Symbol	Test Conditions	Value			Units
			Min	Typ	Max	
Input capacitance	$C_{iss}$	$V_{DS}=100V, V_{GS}=0V$ $f=100kHz$		760		pF
Output capacitance	$C_{oss}$			98		
Reverse transfer capacitance	$C_{rss}$			1		
Effective output capacitance, energy related	$C_{oss(er)}$	$V_{DS}=0V$ to 400V, $V_{GS}=0V$		71		pF
Effective output capacitance, time related	$C_{oss(tr)}$	$V_{DS}=0V$ to 400V, $V_{GS}=0V$		150		pF
$C_{oss}$ stored energy	$E_{oss}$	$V_{DS}=400V, V_{GS}=0V$		5.7		$\mu J$
Total gate charge	$Q_G$	$V_{DS}=400V, I_D=20A,$ $V_{GS} = -5V$ to 12V		23		nC
Gate-drain charge	$Q_{GD}$			5		
Gate-source charge	$Q_{GS}$			11		
Turn-on delay time	$t_{d(on)}$	$V_{DS}=400V, I_D=20A,$ Gate Driver = -5V to +12V, Turn-on $R_{G,EXT}=8.5\Omega,$ Turn-off $R_{G,EXT}=22\Omega$		30		ns
Rise time	$t_r$			8		
Turn-off delay time	$t_{d(off)}$			25		
Fall time	$t_f$			7		
Turn-on energy	$E_{ON}$	Inductive Load, FWD: same device with $V_{GS} = -5V, R_G = 22\Omega,$ $T_J=25^\circ C$		163		$\mu J$
Turn-off energy	$E_{OFF}$			29		
Total switching energy	$E_{TOTAL}$			192		
Turn-on delay time	$t_{d(on)}$	$V_{DS}=400V, I_D=20A,$ Gate Driver = -5V to +12V, Turn-on $R_{G,EXT}=8.5\Omega,$ Turn-off $R_{G,EXT}=22\Omega$		27		ns
Rise time	$t_r$			7		
Turn-off delay time	$t_{d(off)}$			26		
Fall time	$t_f$			6		
Turn-on energy	$E_{ON}$	Inductive Load, FWD: same device with $V_{GS} = -5V, R_G = 22\Omega,$ $T_J=150^\circ C$		144		$\mu J$
Turn-off energy	$E_{OFF}$			26		
Total switching energy	$E_{TOTAL}$			170		

### Typical Performance Diagrams

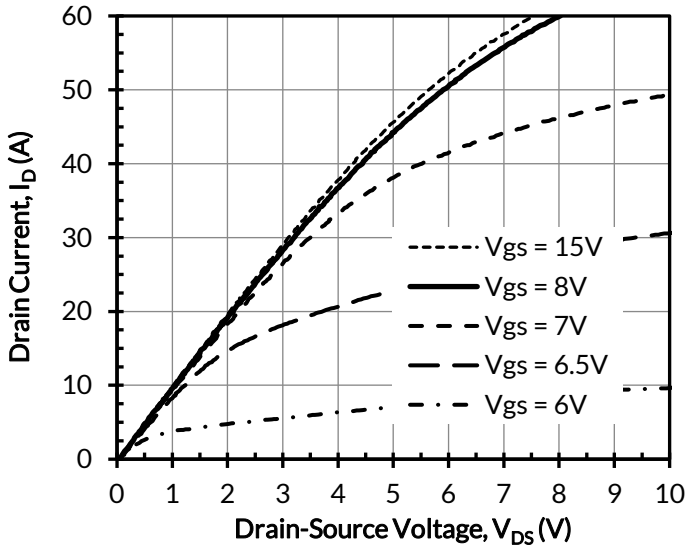


Figure 1. Typical output characteristics at  $T_J = -55^\circ\text{C}$ ,  $t_p < 250\mu\text{s}$

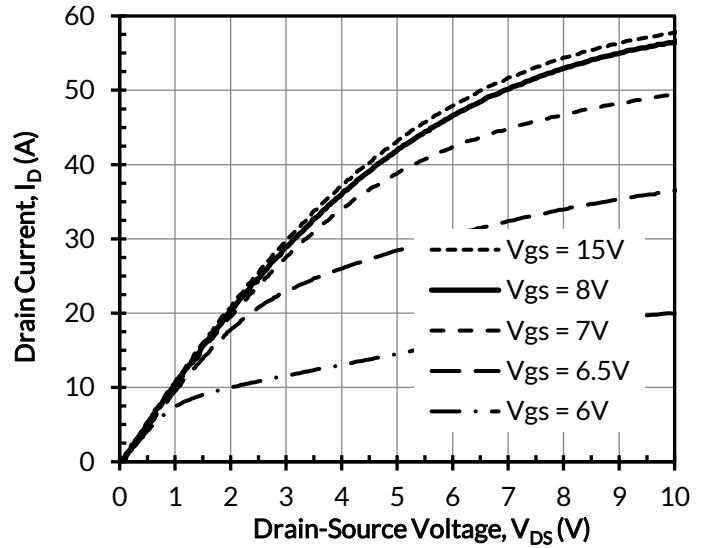


Figure 2. Typical output characteristics at  $T_J = 25^\circ\text{C}$ ,  $t_p < 250\mu\text{s}$

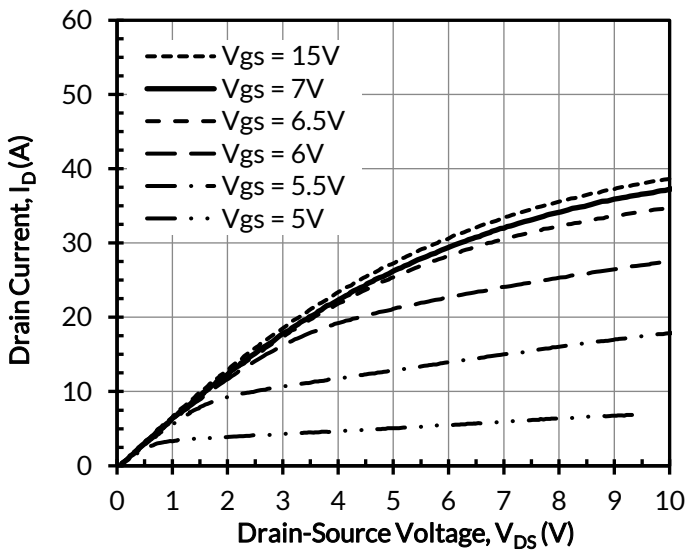


Figure 3. Typical output characteristics at  $T_J = 175^\circ\text{C}$ ,  $t_p < 250\mu\text{s}$

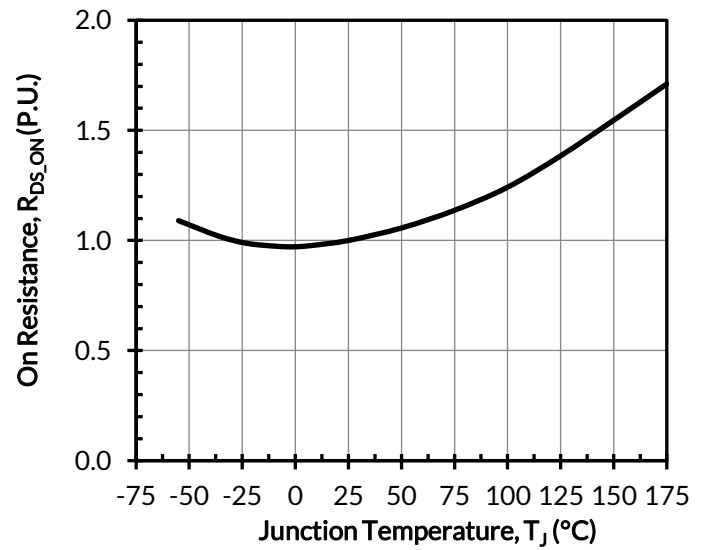


Figure 4. Normalized on-resistance vs. temperature at  $V_{GS} = 12\text{V}$  and  $I_D = 20\text{A}$

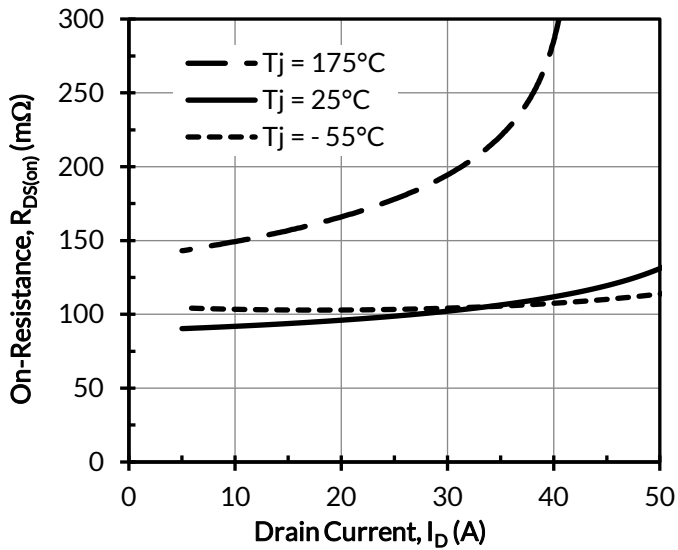


Figure 5. Typical drain-source on-resistances at  $V_{GS} = 12\text{V}$

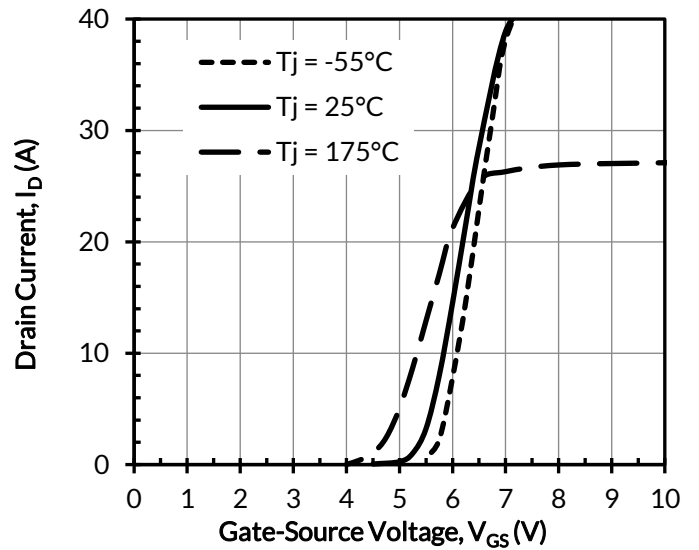


Figure 6. Typical transfer characteristics at  $V_{DS} = 5\text{V}$

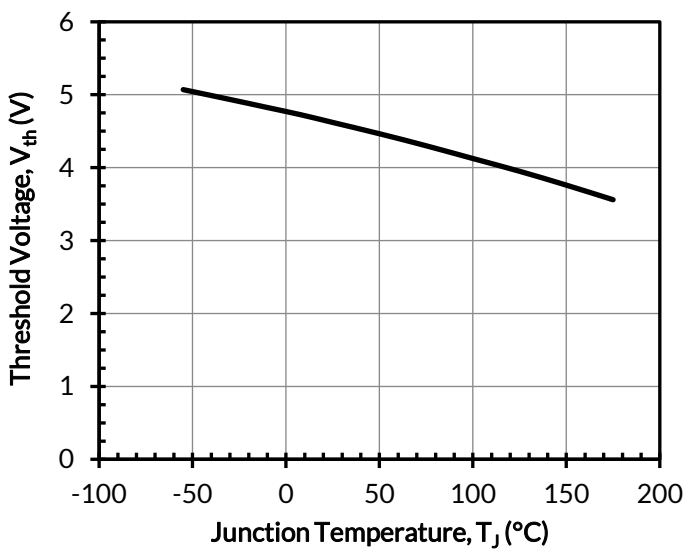


Figure 7. Threshold voltage vs. junction temperature at  $V_{DS} = 5\text{V}$  and  $I_D = 10\text{mA}$

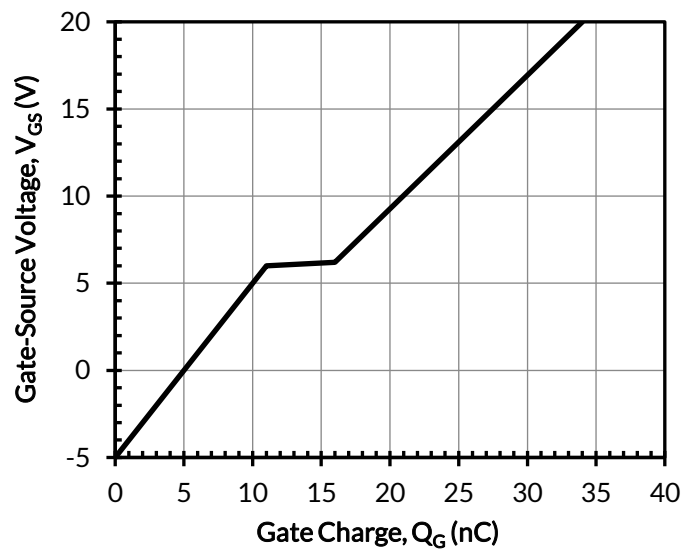


Figure 8. Typical gate charge at  $V_{DS} = 400\text{V}$  and  $I_D = 20\text{A}$

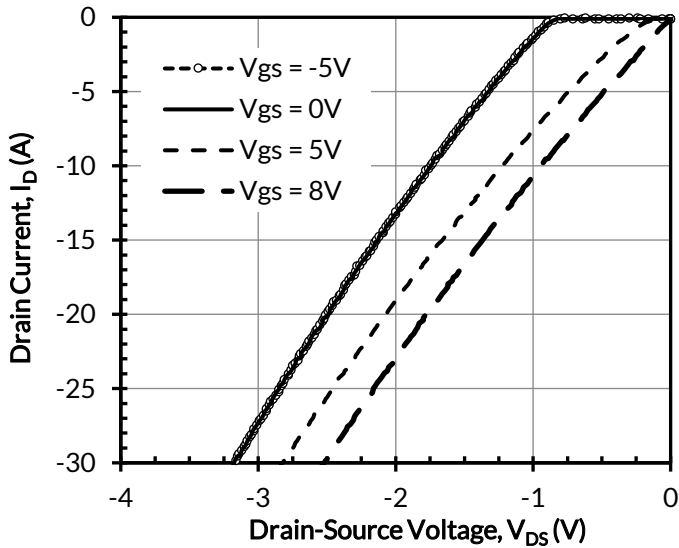


Figure 9. 3rd quadrant characteristics at  $T_J = -55^\circ\text{C}$

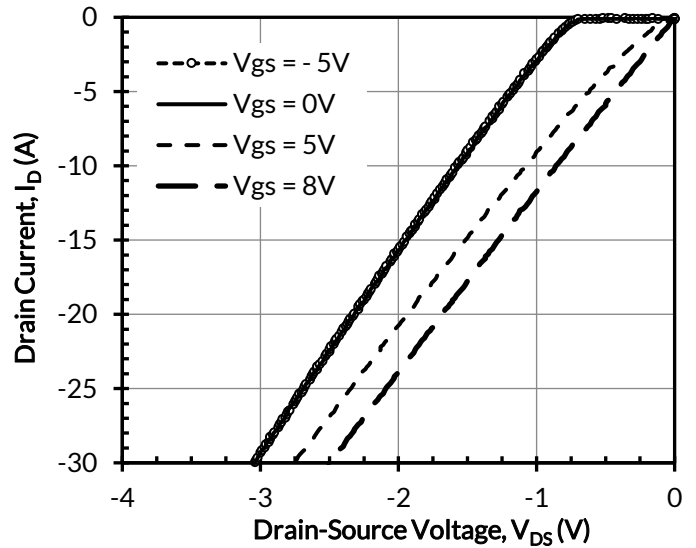


Figure 10. 3rd quadrant characteristics at  $T_J = 25^\circ\text{C}$

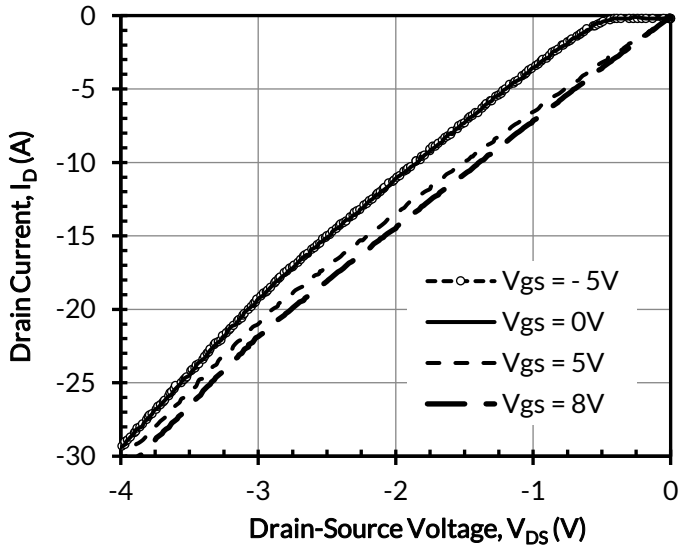


Figure 11. 3rd quadrant characteristics at  $T_J = 175^\circ\text{C}$

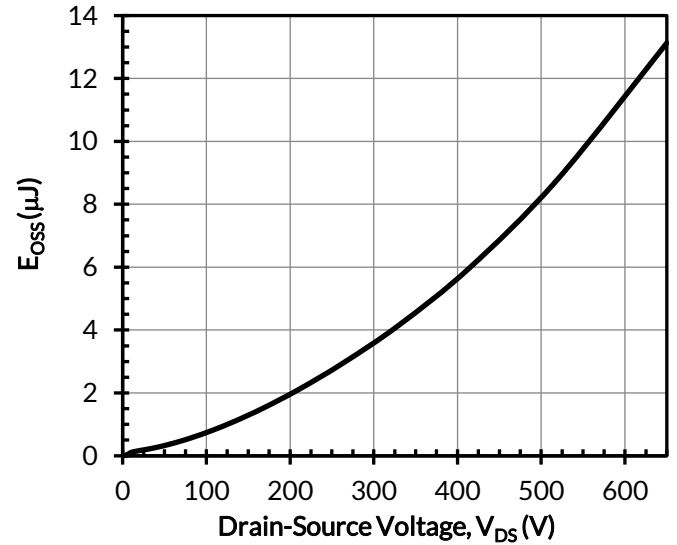


Figure 12. Typical stored energy in  $C_{OSS}$  at  $V_{GS} = 0\text{V}$

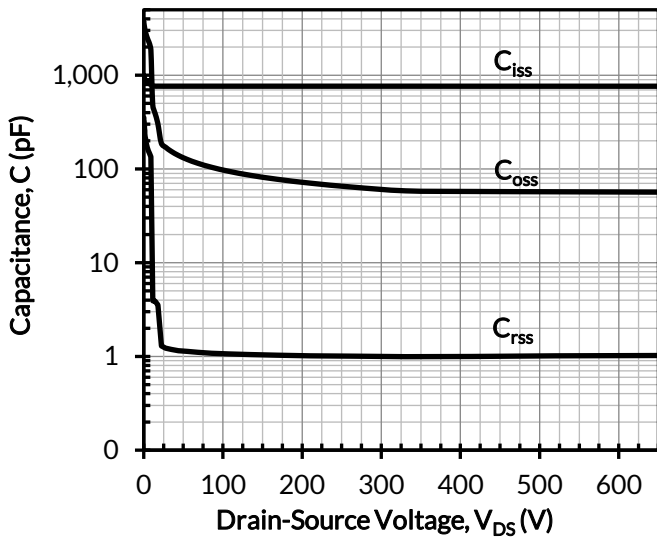


Figure 13. Typical capacitances at  $f = 100\text{kHz}$  and  $V_{GS} = 0\text{V}$

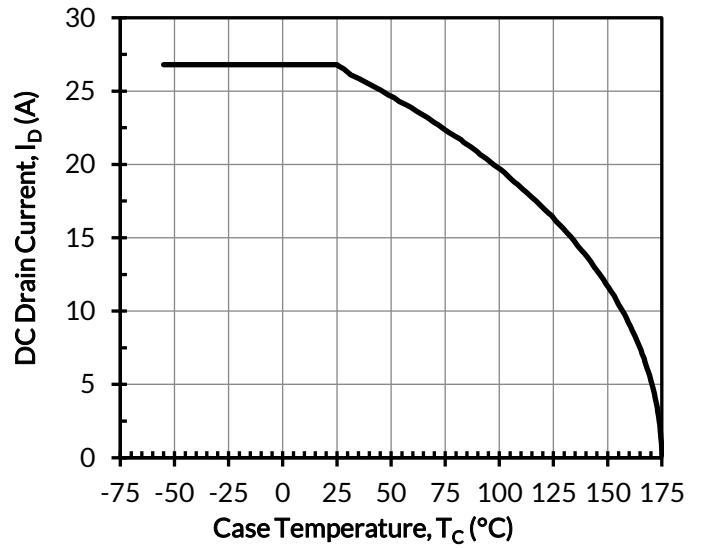


Figure 14. DC drain current derating

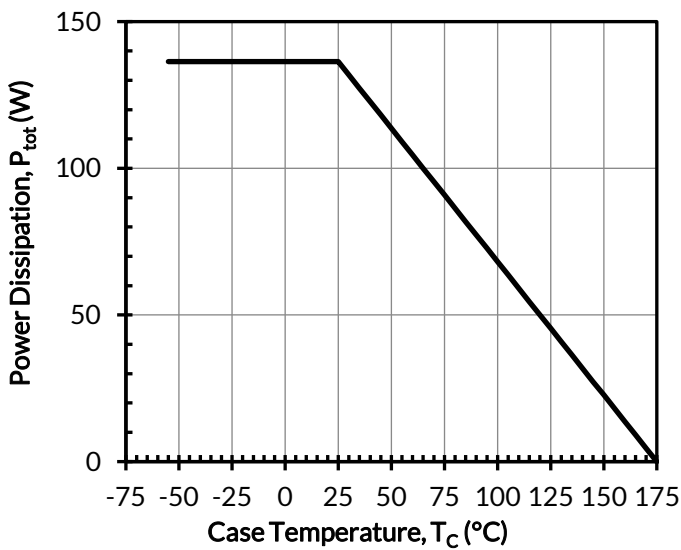


Figure 15. Total power dissipation

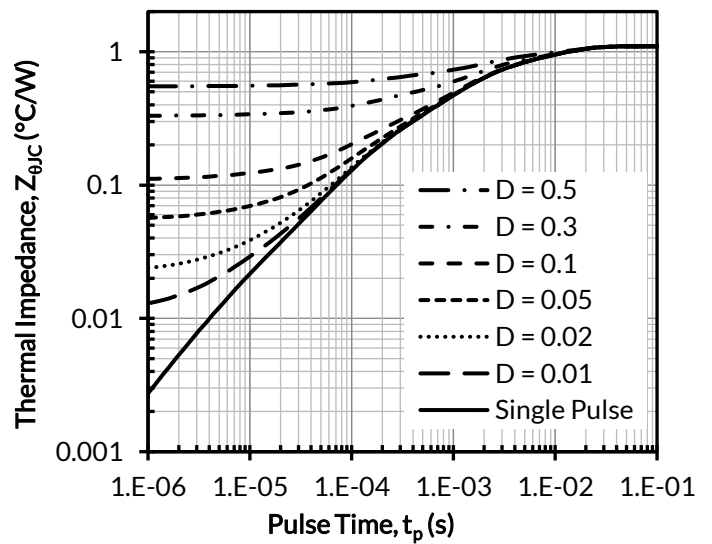


Figure 16. Maximum transient thermal impedance



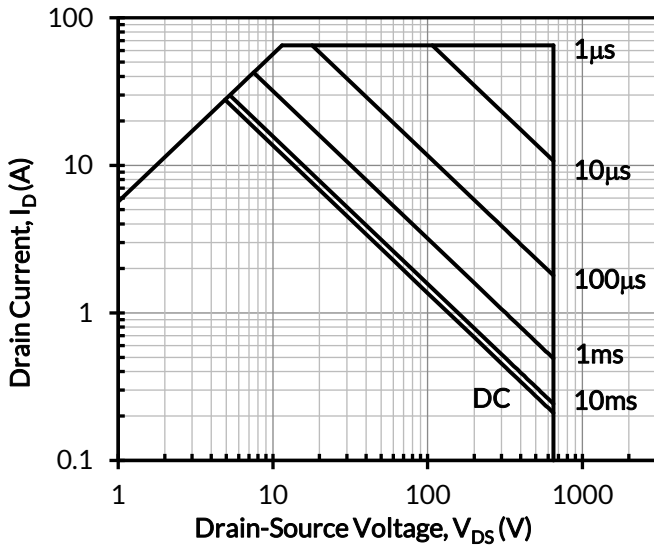


Figure 17. Safe operation area at  $T_C = 25^\circ\text{C}$ ,  $D = 0$ , Parameter  $t_p$

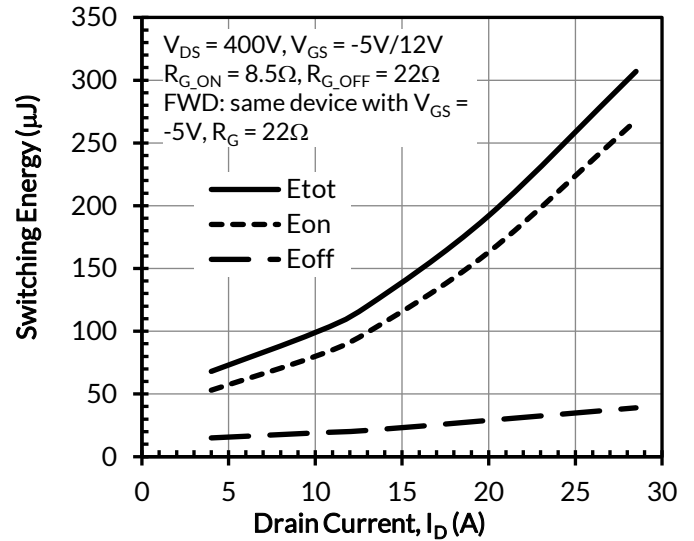


Figure 18. Clamped inductive switching energy vs. drain current at  $T_J = 25^\circ\text{C}$

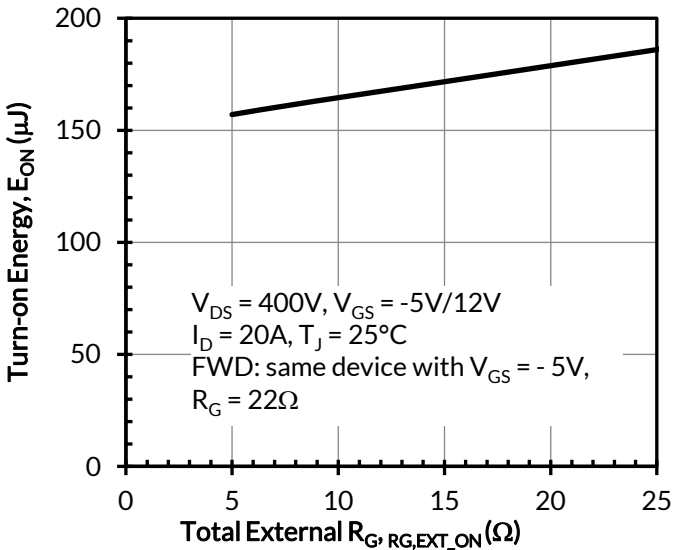


Figure 19. Clamped inductive switching turn-on energy vs.  $R_{G,EXT,ON}$

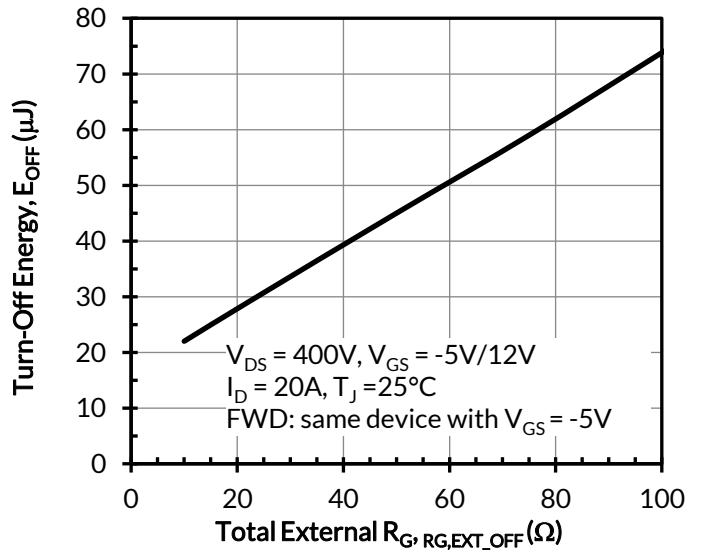


Figure 20. Clamped inductive switching turn-off energy vs.  $R_{G,EXT,OFF}$

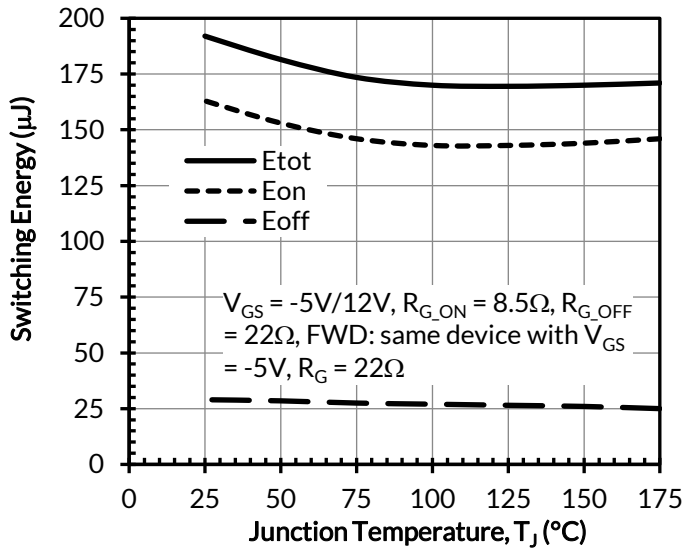


Figure 21. Clamped inductive switching energy vs. junction temperature at  $V_{DS} = 400V$  and  $I_D = 20A$

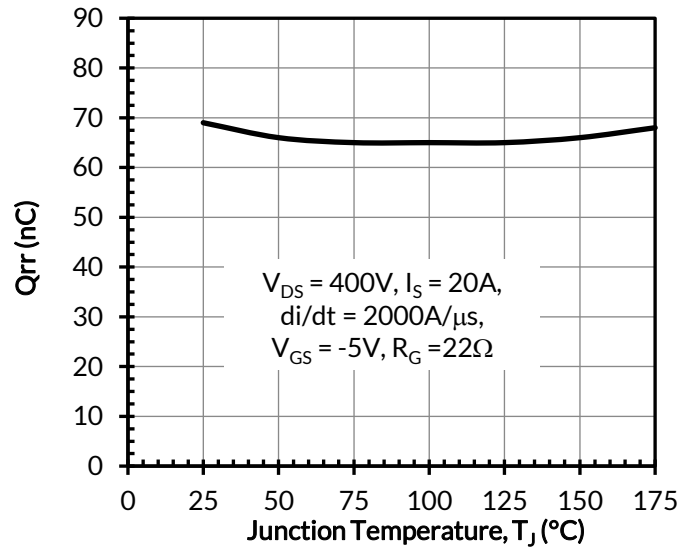


Figure 22. Reverse recovery charge  $Q_{rr}$  vs. junction temperature

## Applications Information

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ( $R_{DS(on)}$ ), output capacitance ( $C_{oss}$ ), gate charge ( $Q_G$ ), and reverse recovery charge ( $Q_{rr}$ ) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high  $dv/dt$  and  $di/dt$  rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see [www.unitedsic.com](http://www.unitedsic.com).

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